

N -Channel Enhancement Mode Power MOSFET

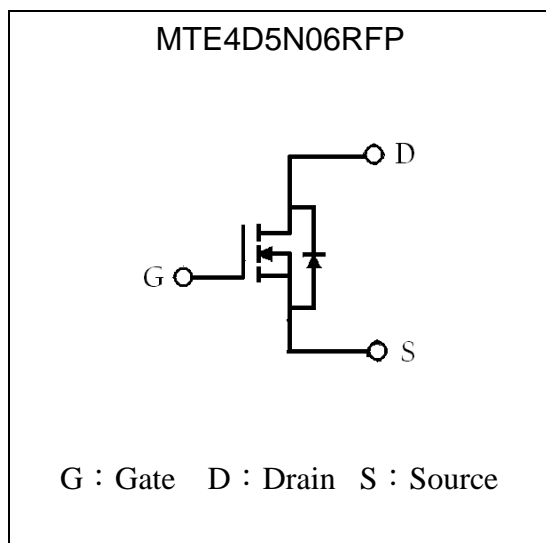
MTE4D5N06RFP

BV_{DSS}	60V	
$I_D @ V_{GS}=10V, T_C=25^\circ C$	64A	
$R_{DS(on)(TYP)}$	$V_{GS}=10V, I_D=29A$	4.5m Ω

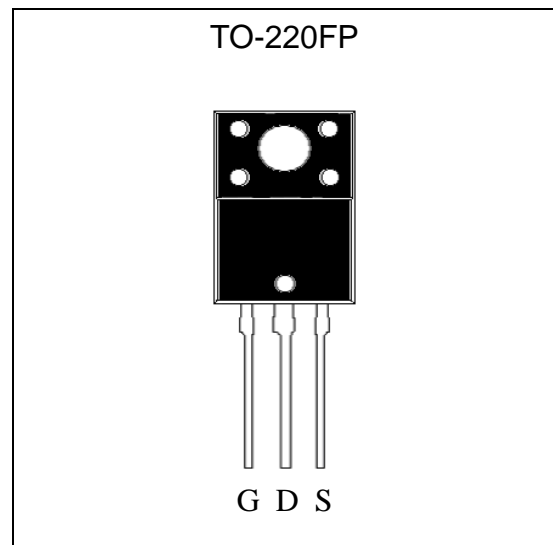
Features

- Low Gate Charge
- Simple Drive Requirement
- Insulating package, front/back side insulating voltage=2500V(AC)
- Pb-free lead plating package

Symbol

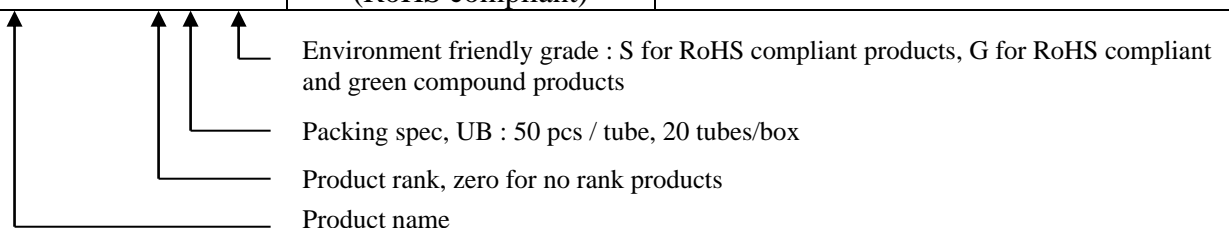


Outline



Ordering Information

Device	Package	Shipping
MTE4D5N06RFP-0-UB-S	TO-220FP (RoHS compliant)	50 pcs/tube, 20 tubes/box, 4 boxes / carton



**Absolute Maximum Ratings** ($T_C=25^{\circ}\text{C}$, unless otherwise noted)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current @ $T_C=25^{\circ}\text{C}$, $V_{GS}=10\text{V}$	I_D	64	A
Continuous Drain Current @ $T_C=100^{\circ}\text{C}$, $V_{GS}=10\text{V}$		40.5	
Continuous Drain Current @ $T_A=25^{\circ}\text{C}$, $V_{GS}=10\text{V}$ (Note 2)	I_{DSM}	14	
Continuous Drain Current @ $T_A=70^{\circ}\text{C}$, $V_{GS}=10\text{V}$ (Note 2)		11.2	
Pulsed Drain Current (Note 3)	I_{DM}	257	
Avalanche Current @ $L=0.1\text{mH}$ (Note 3)	I_{AS}	64	
Avalanche Energy @ $L=1\text{mH}$, $I_D=30\text{A}$, $V_{DD}=25$ (Note 2)	E_{AS}	450	mJ
Repetitive Avalanche Energy @ $L=0.1\text{mH}$ (Note 3)	E_{AR}	4	
Power Dissipation @ $T_C=25^{\circ}\text{C}$ (Note 1)	P_D	42	W
Power Dissipation @ $T_C=100^{\circ}\text{C}$ (Note 1)		16.8	
Power Dissipation @ $T_A=25^{\circ}\text{C}$ (Note 2)	P_{DSM}	2	
Power Dissipation @ $T_A=70^{\circ}\text{C}$ (Note 2)		1.3	
Operating Junction and Storage Temperature Range	T_j, T_{stg}	$-55\sim+150$	$^{\circ}\text{C}$

*100% UIS tested at condition of $L=2\text{mH}$, $I_{AS}=6\text{A}$, $V_{DD}=50\text{V}$.**Thermal Data**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{\theta JC}$	3	$^{\circ}\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient, max (Note 2)	$R_{\theta JA}$	62.5	

- Note :
1. The power dissipation P_D is based on $T_{J(MAX)}=150^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
 2. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2 oz. copper, in a still air environment with $T_A=25^{\circ}\text{C}$. The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.
 3. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150^{\circ}\text{C}$. Ratings are based on low frequency and low duty cycles to keep initial $T_J=25^{\circ}\text{C}$.
 4. The static characteristics are obtained using $<300\mu\text{s}$ pulses, duty cycle 0.5% maximum.
 5. The $R_{\theta JA}$ is the sum of thermal resistance from junction to case $R_{\theta JC}$ and case to ambient.



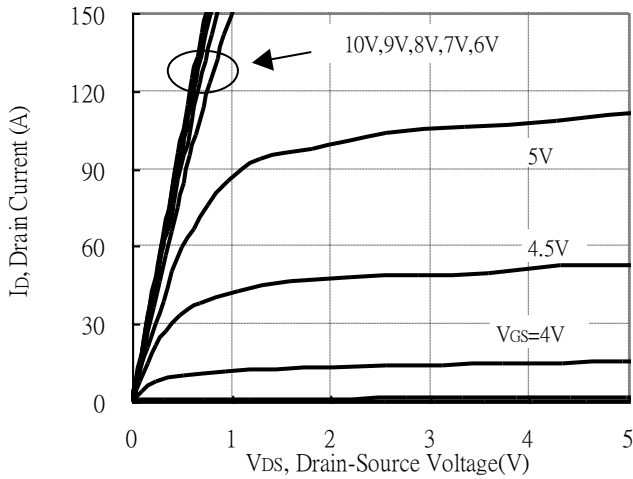
Characteristics (Tc=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	60	-	-	V	V _{GS} =0V, I _D =250μA
ΔBV _{DSS} /ΔT _j	-	0.03	-	V/°C	Reference to I _D =250μA
V _{GS(th)}	2	-	4	V	V _{DS} =V _{GS} , I _D =250μA
I _{GSS}	-	-	±100	nA	V _{GS} =±20V, V _{DS} =0V
I _{DSS}	-	-	1	μA	V _{DS} =48V, V _{GS} =0V
	-	-	25		V _{DS} =48V, V _{GS} =0V, T _J =125°C
R _{DS(ON)} *1	-	4.5	5.9	mΩ	V _{GS} =10V, I _D =29A
G _{FS} *1	-	18.5	-	S	V _{DS} =10V, I _D =10A
Dynamic					
Q _g *1, 2	-	67.6	-	nC	V _{DS} =30V, I _D =29A, V _{GS} =10V
Q _{gs} *1, 2	-	17	-		
Q _{gd} *1, 2	-	16.7	-		
t _{d(ON)} *1, 2	-	32.2	-	ns	V _{DS} =30V, I _D =29A, V _{GS} =10V, R _G =1Ω
t _r *1, 2	-	20.2	-		
t _{d(OFF)} *1, 2	-	63	-		
t _f *1, 2	-	12.2	-		
C _{iss}	-	4420	-	pF	V _{GS} =0V, V _{DS} =30V, f=1MHz
C _{oss}	-	512	-		
C _{rss}	-	45	-		
R _g	-	1.1	-	Ω	f=1MHz
Source-Drain Diode					
I _S *1	-	-	64	A	
I _{SM} *3	-	-	257		
V _{SD} *1	-	0.89	1.2	V	I _F =30A, V _{GS} =0V
t _{rr}	-	30.3	-	ns	I _F =30A, dI _F /dt=100A/μs
Q _{rr}	-	24.3	-	nC	

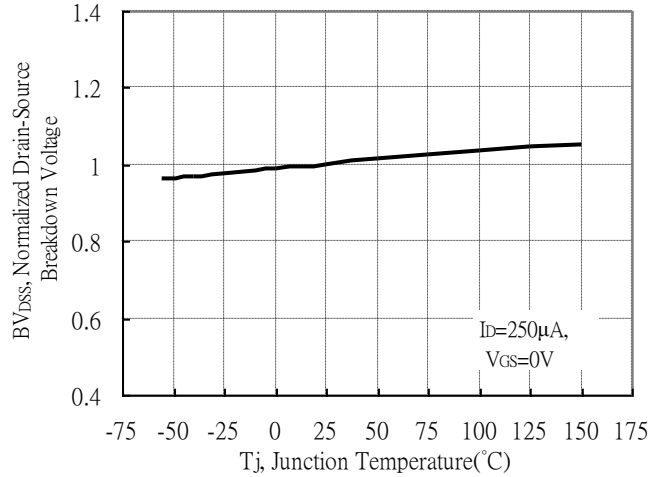
Note : *1.Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%
 *2.Independent of operating temperature
 *3.Pulse width limited by maximum junction temperature.

Typical Characteristics

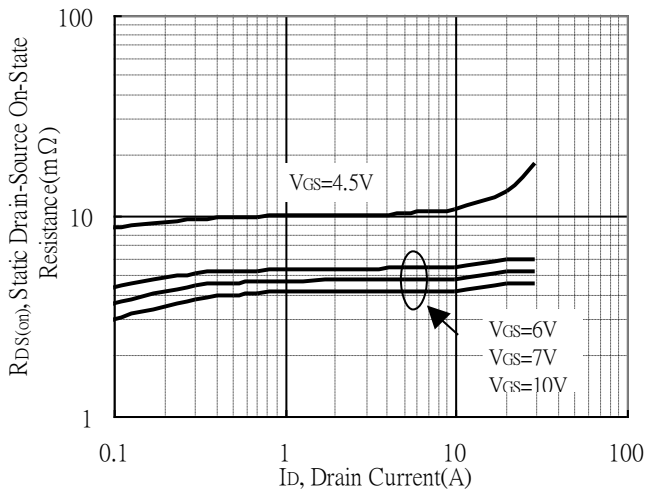
Typical Output Characteristics



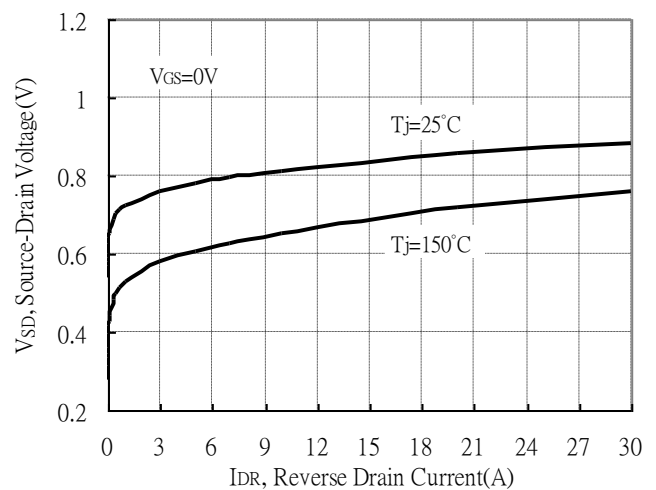
Brekdown Voltage vs Ambient Temperature



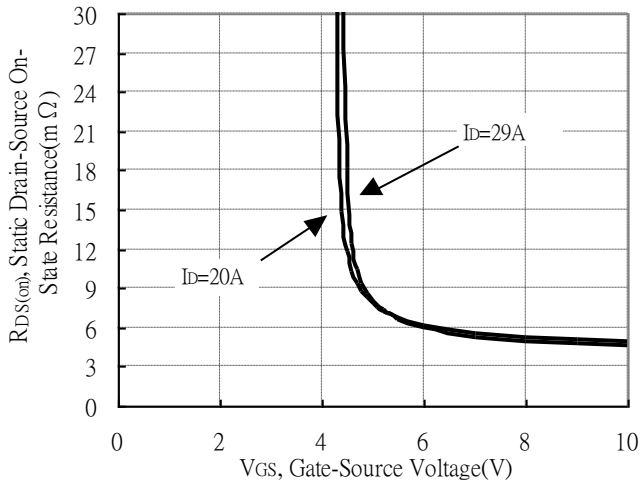
Static Drain-Source On-State resistance vs Drain Current



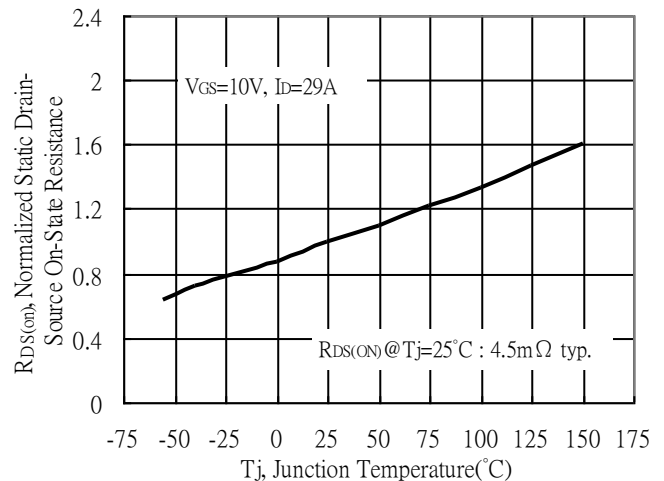
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

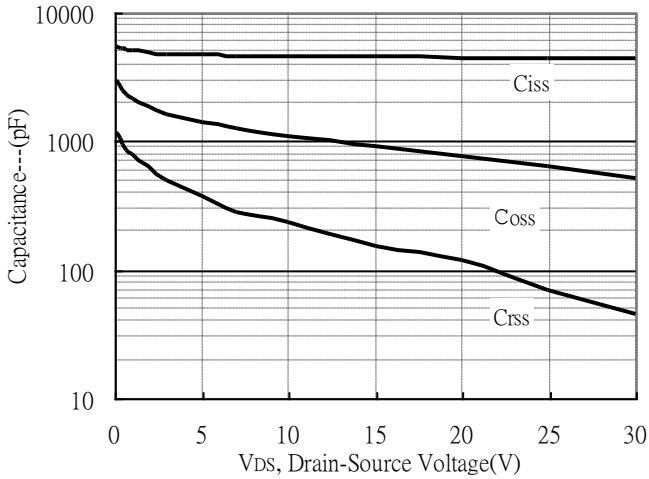


Drain-Source On-State Resistance vs Junction Temperature

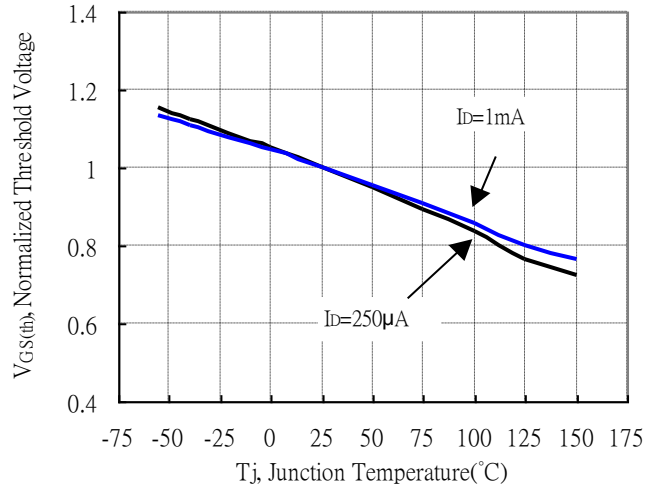


Typical Characteristics(Cont.)

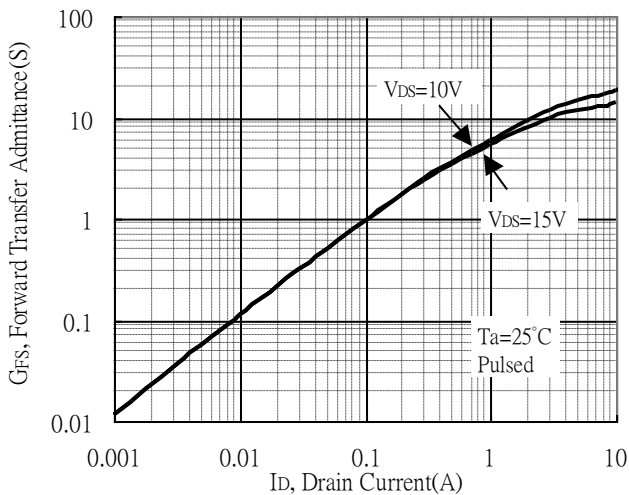
Capacitance vs Drain-to-Source Voltage



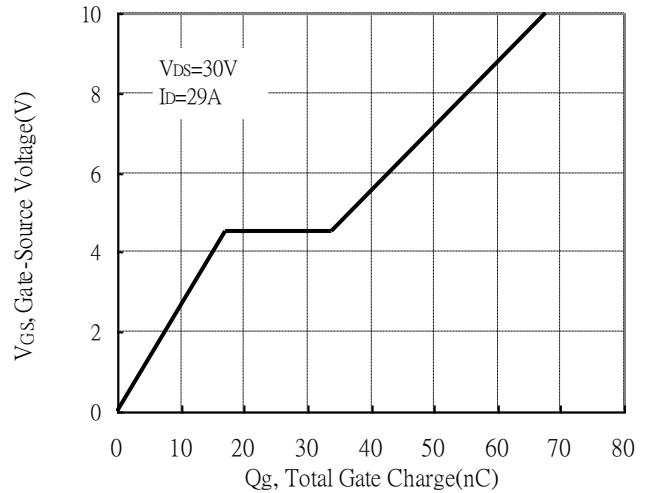
Threshold Voltage vs Junction Temperature



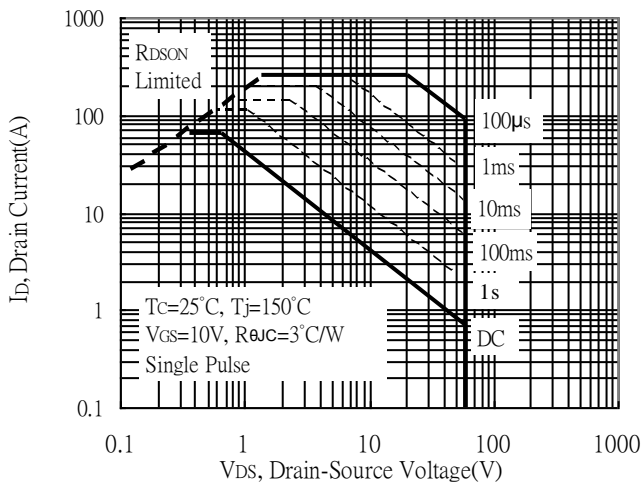
Forward Transfer Admittance vs Drain Current



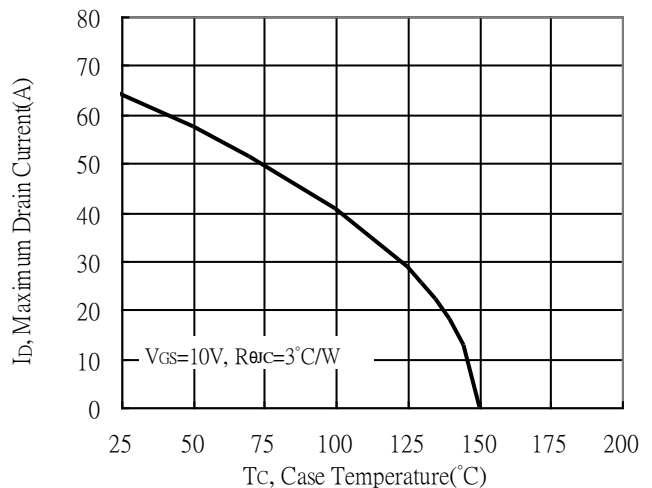
Gate Charge Characteristics



Maximum Safe Operating Area

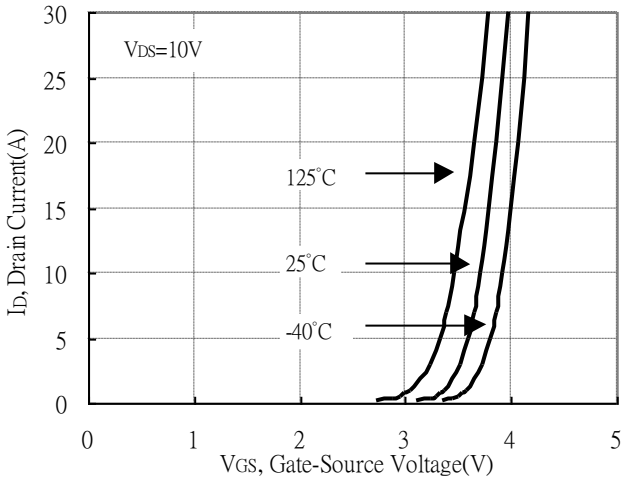


Maximum Drain Current vs Case Temperature

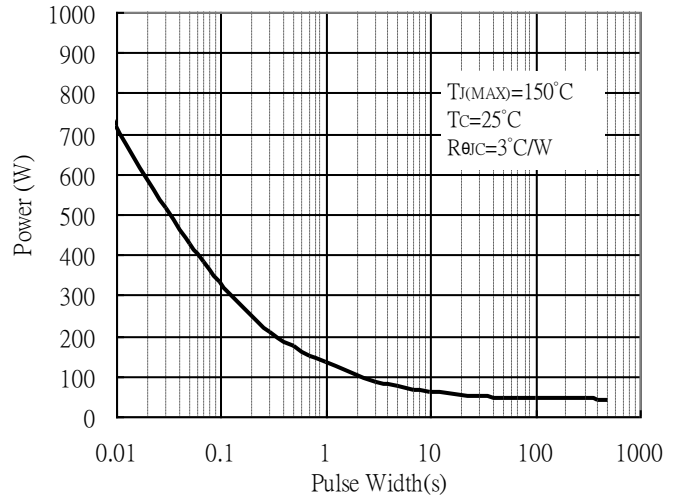


Typical Characteristics(Cont.)

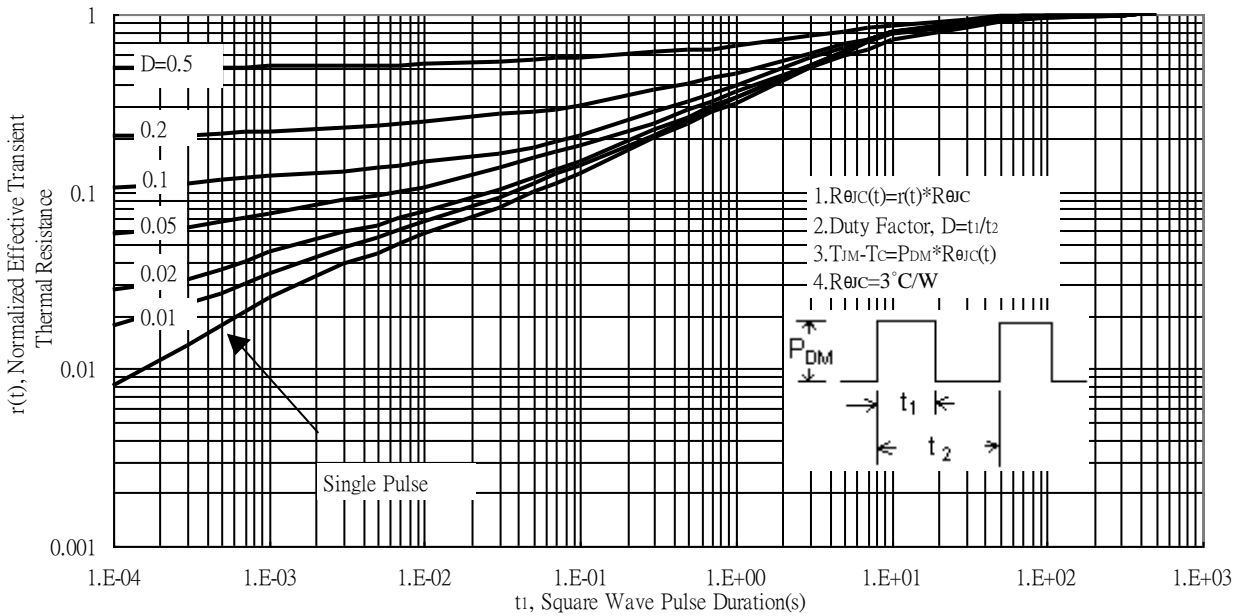
Typical Transfer Characteristics



Single Pulse Power Rating, Junction to Case



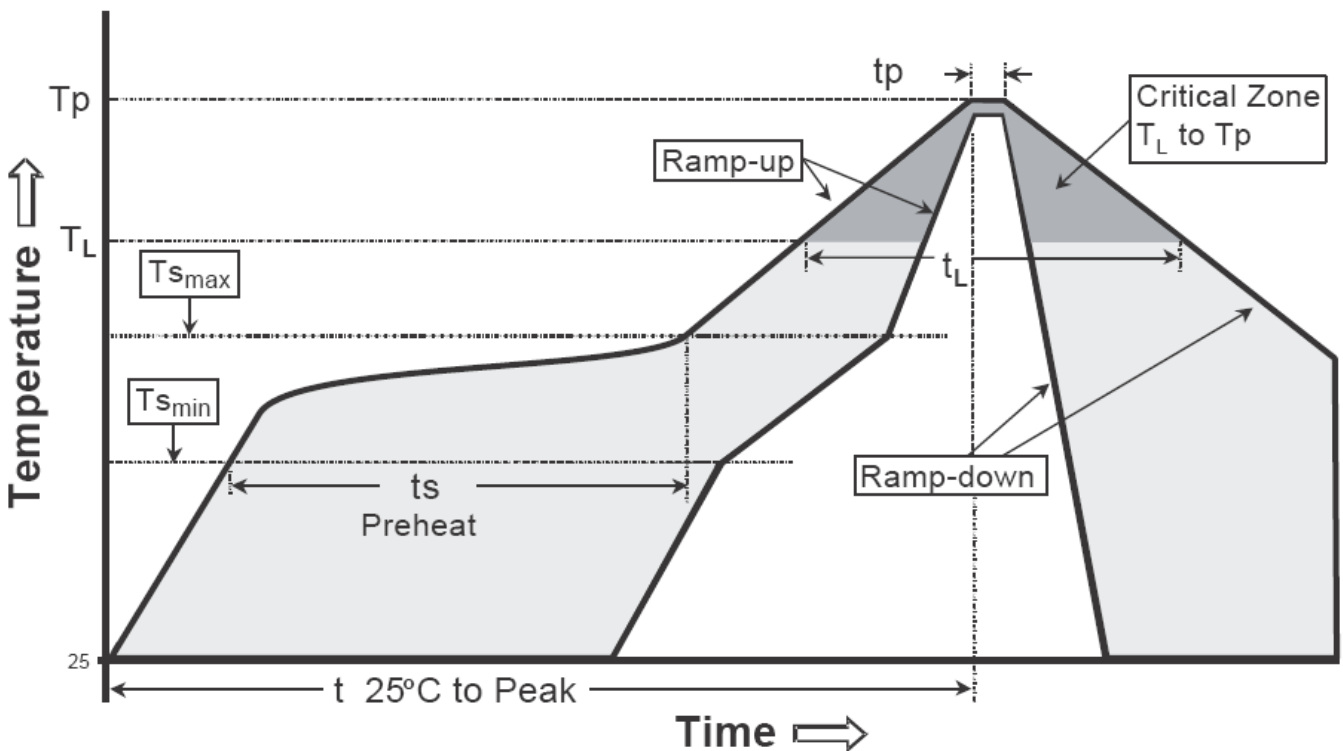
Transient Thermal Response Curves



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

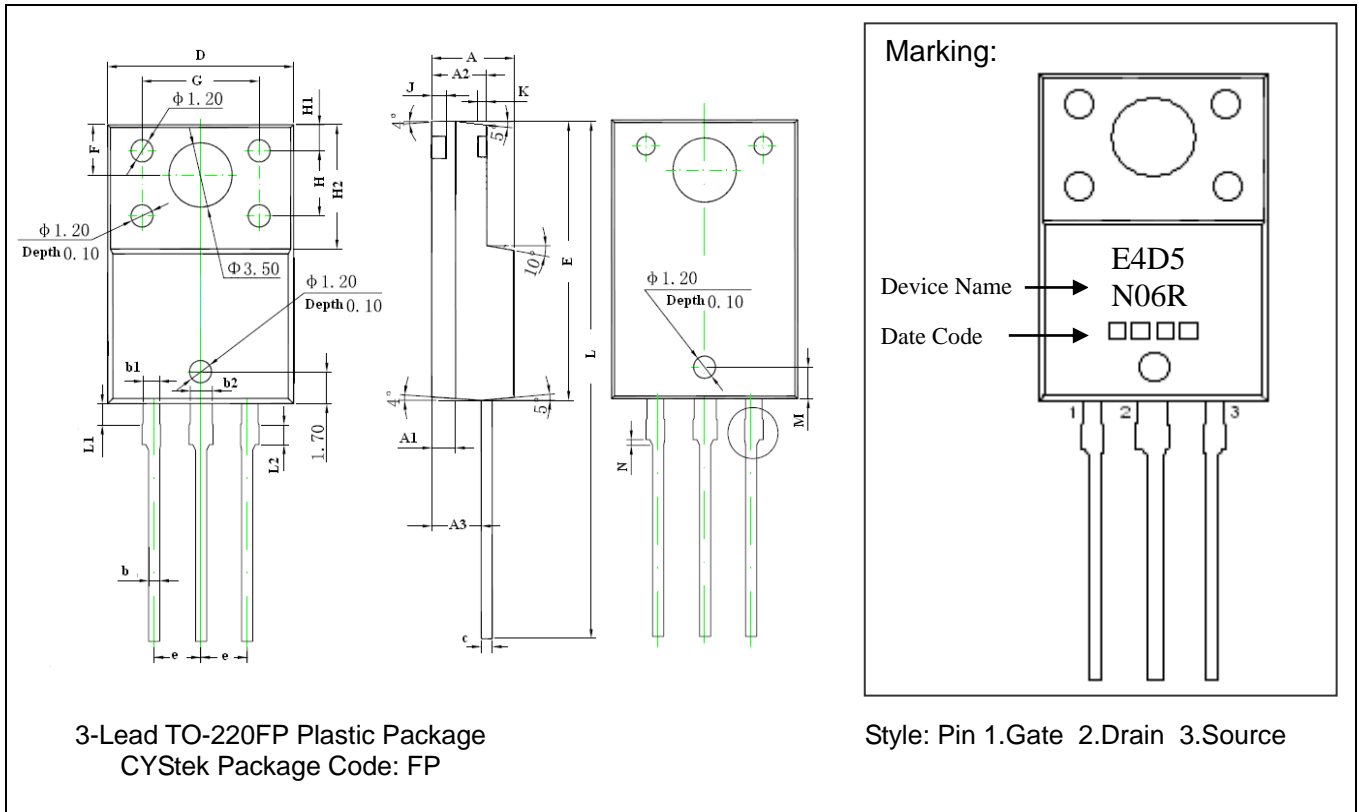
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _{s min})	100°C	150°C
-Temperature Max(T _{s max})	150°C	200°C
-Time(t _{s min} to t _{s max})	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

TO-220FP Dimension



*Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.171	0.183	4.35	4.65	G	0.246	0.258	6.25	6.55
A1	0.051 REF		1.300 REF		H	0.138 REF		3.50 REF	
A2	0.112	0.124	2.85	3.15	H1	0.055 REF		1.40 REF	
A3	0.102	0.110	2.60	2.80	H2	0.256	0.272	6.50	6.90
b	0.020	0.030	0.50	0.75	J	0.031 REF		0.80 REF	
b1	0.031	0.041	0.80	1.05	K	0.020		0.50 REF	
b2	0.047 REF		1.20 REF		L	1.102	1.118	28.00	28.40
c	0.020	0.030	0.500	0.750	L1	0.043	0.051	1.10	1.30
D	0.396	0.404	10.06	10.26	L2	0.036	0.043	0.92	1.08
E	0.583	0.598	14.80	15.20	M	0.067 REF		1.70 REF	
e	0.100 *		2.54*		N	0.012 REF		0.30 REF	
F	0.106 REF		2.70 REF						

- Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

Important Notice:

- All rights are reserved. Reproduction in whole or in part is prohibited without the prior written approval of CYStek.
- CYStek reserves the right to make changes to its products without notice.
- CYStek **semiconductor products are not warranted to be suitable for use in Life-Support Applications, or systems.**
- CYStek assumes no liability for any consequence of customer product design, infringement of patents, or application assistance.